Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/695,810	CHANG ET AL.	
Examiner	Art Unit	
Hana A. Sanei	2879	

SEARCHED			
Class	Subclass	Date	Examiner
445	24	1/23/2006	HAS
			_

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
For text search see attached Search History	1/23/2006	HAS